

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination FILIPPI ET AL.	
		Examiner Helen Rossoshek	Art Unit 2825	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,353,801	03-2002	Sercu et al.	702/65
*	C	US-6,907,583	06-2005	Abt et al.	716/1
*	D	US-6,367,053	04-2002	Belk et al.	716/2
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	M	US-			

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.